

<b>Notice of References Cited</b>	Application/Control No. 10/665,120	Applicant(s)/Patent Under Reexamination MIYAZAWA, TAKASHI	
	Examiner Donna V. Lui	Art Unit 2629	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0171607	11-2002	Senda et al.	345/55
	B	US-			
	C	US-			
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**FOREIGN PATENT DOCUMENTS**

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